Search Notes (continued)



Application/Control No.	Applicant(s)/Patent und Reexamination	Applicant(s)/Patent under Reexamination	
10/717,679	KONG ET AL.	KONG ET AL.	
Examiner	Art Unit		
Duy M. Dang	2624		

SEARCHED				
Class	Subclass	Date	Examiner	
382	232-236 275	5/18/2007	DD	
375	240.13 240			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (uspto, derwen, pgpub, jpo, epo), see printouts	5/18/2007	DD		
Inventor search (east and IEEE), see printouts				
IEEE search, see printouts				
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